

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BENSON ET AL.	
		10/713,174	Examiner	Art Unit
		Robert Shiao	1626	Page 1 of 3

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*	B	US-2,995,542	08-1961	BROWN HARVEY A	526/243
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Luheshi et al., 1990, Tetrahedron Letters, 31(45), page 6561-6564.
	V	Hashimoto et al., 1991, CAS: 115:207678.
	W	Chiymaru et al., 1973, CAS: 78:144282.
	X	Kato et al., 1973, CAS: 78:124224.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	W	Chiyomaru et al., 1972, CAS: 77:164667
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	V	Iwakura et al., 1980, CAS: 92:41570.✓
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